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Mesoscopic Description of Radiative Heat Transfer at the Nanoscale

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We present a formulation of the nanoscale radiative heat transfer using concepts of mesoscopic physics. We introduce the analog of the Sharvin conductance using the quantum of thermal conductance. The formalism provides a convenient framework to analyze the physics of radiative heat transfer at the nanoscale. Finally, we propose a radiative heat transfer experiment in the regime of quantized conductance.

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It was discovered in the late 1960s that the radiative heat transfer (RHT) between two metallic parallel plates can be larger than predicted by using the blackbody radiation form [1–3]. It is now known that this anomalous RHT is due to the contribution of evanescent waves and becomes significant when the distance separating the interfaces becomes smaller than the thermal wavelength $\lambda_{\text{th}} = \frac{\hbar c}{k_B T}$, where \hbar is Planck's constant, k_B is Boltzmann's constant, c is the light velocity, and T is the temperature. Using the framework of fluctuational electrodynamics [4], Polder and van Hove (PvH) were able to derive a general form of the RHT accounting for the optical properties of the media [5]. Since this seminal contribution, several reports have been published in the literature [6–11]. A quantum-mechanical derivation [12] has confirmed these results obtained within the framework of fluctuational electrodynamics. While the first papers considered metals, it has been realized that the RHT at the nanoscale can be further enhanced for dielectrics due to the contribution of surface phonon polaritons [13,14]. Recent reviews can be found in Refs. [15–18].

The first attempts to measure a heat flux between metallic surfaces at room temperature and micrometric distances have proved to be inconclusive [19,20]. Experiments in the nanometric regime have clearly demonstrated the transfer enhancement [21,22]. Yet the lack of good control of the tip geometry did not allow quantitative comparison with theory. More recent experiments [23,24] are performed by using silica, taking advantage of the flux enhancement due to the resonant contribution of surface phonon polaritons. A good agreement between PvH theory and experiments has been reported [24].

The purpose of this Letter is to establish a link between the PvH form of the radiative heat flux and the formalism of transport in mesoscopic physics. It will help to develop a more physical understanding of the RHT at the nanoscale, which also clarifies how losses and nonlocal effects determine the maximal achievable heat flux [10]. Finally, we will show that this reformulation raises the prospect of

observing quantized conductance for systems with sizes on the order of the thermal wavelength λ_{th} .

We start our discussion with the PvH form of the RHT. We consider a vacuum gap with width d separating two homogeneous half-spaces labeled medium 1 and 2 [see Fig. 1(a)]. Then, the heat flux is [5,16]

$$\Phi(d, T_1, T_2) = \int_0^\infty \frac{d\omega}{2\pi} [\Theta(\omega, T_1) - \Theta(\omega, T_2)] \times \sum_{j=s,p} \left[\int_0^{k_0} \frac{d^2\kappa}{4\pi^2} \frac{(1 - |r_j^1|^2)(1 - |r_j^2|^2)}{|1 - r_j^1 r_j^2 e^{-2i\gamma d}|^2} + \int_{k_0}^\infty \frac{d^2\kappa}{4\pi^2} \frac{4 \text{Im}(r_j^1) \text{Im}(r_j^2) e^{-2 \text{Im}(\gamma) d}}{|1 - r_j^1 r_j^2 e^{-2 \text{Im}(\gamma) d}|^2} \right], \quad (1)$$

where $\kappa = (k_x, k_y)$ and $\gamma = \sqrt{k_0^2 - \kappa^2}$ are the parallel and normal wave vector, respectively, $\Theta(\omega, T) = \hbar\omega / [\exp(\hbar\omega/k_B T) - 1]$ is the mean energy of a harmonic oscillator, $k_0 = \omega/c$, $r_j^{1,2}$ are the usual Fresnel factors for s - or p -polarized waves, and the sum is carried out over $j = s(TE), p(TM)$ and accounts for the two polarizations. In this expression, we have clearly separated the propagating ($\kappa < k_0$) from the evanescent wave contribution ($\kappa > k_0$). The first one can be shown to be described by the usual radiometric approach [16]. In particular, the term $1 - |r_j^1|^2$, which is the interface transmittivity, is exactly the emissivity of the interface of medium 1. It is thus

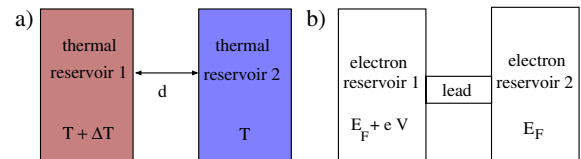


FIG. 1 (color online). Sketch of the conductance geometry: (a) Two thermal reservoirs are separated by a vacuum gap with width d ; (b) two electron reservoirs with a voltage difference V are connected through a nanowire.

tempting to extend the definition of the emissivity to evanescent waves. This has been proposed in Ref. [13], where $\text{Im}(r_j^1)$ was introduced as a generalized emissivity. Obviously, the generalized emissivity is larger than 1 since it accounts for an enhanced RHT. A drawback of this approach is that it does not provide any physical insight in the meaning of an emissivity larger than 1.

A different interpretation, regarding the evanescent contribution only, was given by Pendry [8] by using the single interface local density of states (DOS) $\text{Im}(r_j^1) \times \exp[-2\text{Im}(\gamma)z]|_{z=0}$ in the space $(\boldsymbol{\kappa}, z, \omega)$. Here, the term local refers to the fact that we introduce the DOS in direct space at a distance z above the interface. In summary, the first approach suggests to consider that $\text{Im}(r_j^{1,2})$ is a generalized emissivity, whereas the second approach emphasizes the fact that $\text{Im}(r_j^{1,2})$ is proportional to the local DOS.

The interpretation in terms of local DOS is interesting, as it indicates that the enhancement of the RHT at the nanoscale is due to an enhancement of the DOS. Hence, it would be enlightening to develop a formulation of the RHT that highlights the number of modes (NOM) involved. Such a formulation has been developed in the context of charge transport in mesoscopic physics and is known as Sharvin conductance when the contact area is much larger than the electron wavelengths and Landauer formalism when the size is on the order of the wavelength so that the NOM involved in the transport becomes discrete.

Before reformulating the heat flux in a Landauer-like way, let us recall the structure of the electrical conductivity in the mesoscopic regime. When considering that the dephasing length and the mean free paths are much larger than all the relevant length scales, the electrons can be described by their wave functions. Hence, the conduction through a constriction or nanowire [see Fig. 1(b)] can be described by a scattering matrix that connects the incoming channels to the outgoing channels. It follows that the charge transport can be described by means of a sum over all the modes [25,26]

$$I = \frac{2e}{h} \int dE \sum_n T_n(E) [f_1(E) - f_2(E)], \quad (2)$$

where e is the electron charge, $T_n(E)$ is the transmission probability of a mode n , and $f_1(E) = 1/\{\exp[(E - E_F - eV)/k_B T] + 1\}$ and $f_2(E) = 1/\{\exp[(E - E_F)/k_B T] + 1\}$ are the Fermi-Dirac distributions with E_F the Fermi energy. For small applied voltages V , we obtain

$$I = \frac{2e^2}{h} \int dE \sum_n T_n(E) \left(-\frac{\partial f_0(E)}{\partial E} \right) V, \quad (3)$$

where $2e^2/h$ is the quantum of conductance and $f_0 = f_2$. For temperatures $k_B T \ll E_F$, this result reduces to the Landauer formula

$$I = \frac{2e^2}{h} \sum_n T_n(E_F) V. \quad (4)$$

To derive such a formulation for the RHT case, we consider a situation where the two temperatures are close enough so that $T_1 = T + \Delta T$ and $T_2 = T$ assuming that $\Delta T \ll T$. Then, we can write the flux Φ as

$$\Phi = \sum_{j=s,p} \int \frac{d\omega}{2\pi} \left[\frac{\partial}{\partial T} \Theta(\omega, T) \right] \Delta T \int \frac{d^2\boldsymbol{\kappa}}{4\pi^2} T_j^{12}(\omega, \boldsymbol{\kappa}, d). \quad (5)$$

Here, we have introduced the notation

$$T_j^{12}(\omega, \boldsymbol{\kappa}, d) = \begin{cases} \frac{(1-|r_j^1|^2)(1-|r_j^2|^2)}{|D_j|^2}, & \boldsymbol{\kappa} \leq k_0, \\ \frac{4\text{Im}(r_j^1)\text{Im}(r_j^2)e^{-2\text{Im}(\gamma)d}}{|D_j|^2}, & \boldsymbol{\kappa} > k_0, \end{cases} \quad (6)$$

where $D_j = 1 - r_j^1 r_j^2 \exp(2i\gamma d)$ is the Fabry-Pérot-type denominator. For propagating modes, $T_j^{12}(\omega, \boldsymbol{\kappa}, d)$ is the two interfaces transmission factor (TF) and takes values in the interval $[0, 1]$. It follows that the heat flux is limited by the blackbody result. Hence, the expression strongly suggests to consider that $T_j^{12}(\omega, \boldsymbol{\kappa}, d)$ is also a TF for the evanescent modes. As shown in Ref. [8], T_j^{12} is indeed smaller than 1. This maximal value is reached if $|r_j^1||r_j^2| = e^{2\gamma d}$, which, for example, can be satisfied for s - and p -polarized modes in the case of frustrated total internal reflection [27] when considering dielectrics and also for coupled surface modes (CSMs).

By comparing the expression in Eq. (3) with Eq. (5), one can see that we have already formulated the heat flux equation in a very similar manner. The sum over transverse modes is given by the integral $\int d^2\boldsymbol{\kappa}/4\pi^2$. In order to get a manifestly Landauer-like structure, we need to integrate the modes over all energies. We first introduce the dimensionless variable $u = \hbar\omega/k_B T$. Then, by interchanging the order of integration we cast the heat flux in the form

$$\Phi = \frac{\pi^2}{3} \frac{k_B^2 T}{h} \left(\sum_{j=s,p} \int \frac{d^2\boldsymbol{\kappa}}{(2\pi)^2} \bar{T}_j^{12} \right) \Delta T, \quad (7)$$

where $\pi^2 k_B^2 T/3h$ is the universal quantum of thermal conductance [28,29]. Here, we have introduced the mean transmission factor (MTF)

$$\bar{T}_j^{12} = \frac{\int_0^\infty du f(u) T_j^{12}(u, \boldsymbol{\kappa}, d)}{\int_0^\infty du f(u)}, \quad (8)$$

where $f(u) = u^2 e^u / (e^u - 1)^2$ and $\int_0^\infty f(u) du = \pi^2/3$. This is a new quantity which resembles the transmission probability for the electrons in the Landauer formula in Eq. (4). When dealing with electrons, only the TF at the Fermi energy is relevant because of the particular form of the Fermi-Dirac distribution. By contrast, when dealing with bosons, we need to introduce a TF averaged over all

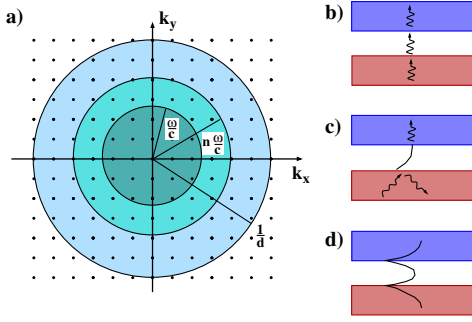


FIG. 2 (color online). Illustration of the contribution of (b) propagating modes ($\kappa < k_0$), (c) modes propagating in the dielectric but evanescent in the gap ($k_0 < \kappa < nk_0$), and (d) evanescent modes confined in the gap ($\kappa > nk_0$).

energies. Let us stress that \bar{T}_j^{12} is always smaller than 1. This property follows directly from the same property of T_j^{12} and the definition of the MTF. Hence, we have now a new interpretation of the physical meaning of the term involving $\text{Im}(r_j^{1,2})$ in Eq. (1). Instead of interpreting $\text{Im}(r_j^{1,2})$ as the local DOS or generalized emissivity of a single interface, we consider now the two-interface system (the gap) and define a TF averaged over all energies for a mode with specified κ . In this picture, the enhancement of the heat flux appears as the consequence of the increase of the NOM contributing to the RHT. We provide in Fig. 2(a) a schematic representation of the modes in the (k_x, k_y) plane, from which it becomes clear that the number of transverse modes diverges. For $\kappa < k_0$, we have the usual thermal radiation due to propagating modes; for $k_0 < \kappa < nk_0$, there is a contribution of modes which can be viewed as frustrated total internal reflection when dealing with dielectrics. Finally, for $\kappa > nk_0$, we have the contribution of CSMs confined in the gap. It remains to be studied under which conditions the TF takes significant values.

A detailed study of the TF $T(\omega, \kappa, d)$ is reported in Ref. [30]. The key results are as follows. For a gap thickness d larger than the thermal wavelength λ_{th} , the TF is negligible for evanescent waves ($k_0 < \kappa$) and oscillates between 0 and 1 with frequency for propagating waves. It is a Fabry-Pérot-type behavior. For a gap thickness of 100 nm, the TF tends to 1 for both propagating waves and waves with frustrated total reflection ($k_0 < \kappa < nk_0$), thereby contributing to a significant enhancement of the flux. As the TF tends indeed to 1 for all frequencies (for s and p polarization), the contribution of these modes is simply given by the DOS $\approx 2(n^2 \lambda_{\text{th}}^{-2} / 4\pi)$ times the thermal quantum of conductance in agreement with previously reported results [27,31].

The value of the TF $T(\omega, \kappa, d)$ for CSMs has a more subtle structure. It is essentially negligible everywhere in the (ω, κ) plane except along the surface mode dispersion relation where it is close to 1 (see Figs. 1 and 2 in [30]). Hence, after averaging over frequencies, the MTF drops by

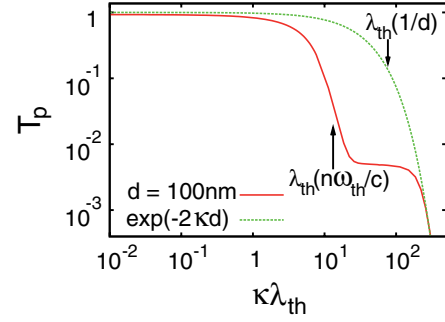


FIG. 3 (color online). Plot of \bar{T}_p^{12} and $\exp(-2\kappa d)$ for 100 nm by choosing temperature $T = 300$ K and two SiC [39] slabs. The modes with $\kappa < nk_0$ have $\bar{T}_p^{12} \approx 1$. The surface phonon polaritons with $\kappa > nk_0$ have a relatively small MTF but give the dominant contribution to the heat flux due to the large number of contributing modes. The MTF shows for very large κ an exponential cutoff $\propto \exp(-2\kappa d)$.

2 orders of magnitude as seen in Fig. 3. We also see in Fig. 4(a) that this drop is smaller for silica than for SiC. This is because, in the case of silica, there are more different surface modes contributing at different frequencies. Despite the low value of the MTF for surface modes, the number of additional surface modes is so large that the RHT is dominated by the CSM contribution at a small distance as seen in Fig. 4(b).

It is clear from the above discussion that the enhanced flux is due to the contribution of surface modes with a large value of κ . In Ref. [30], we discuss the cutoff value of κ which limits the contribution of the CSMs in detail. It is roughly given by $1/d$ as indicated in the graph of Fig. 3. A more precise discussion shows [30] that the losses play a key role in defining the exact position of the cutoff. It is given for $T(\omega, \kappa, d)$ at the surface resonance by $\kappa > \log[2/\text{Im}(\epsilon)]/d$, which also sets a cutoff for the MTF.

We finally turn to the ultimate limit of the RHT. So far, it seems that the RHT conductance can diverge as $1/d^2$, since the DOS $\propto 1/d^2$. Yet, it is known that there is a cutoff value for the spatial wave vectors of the phonons given by π/a , where a is the lattice constant. This is equivalent to accounting for nonlocal properties of the material [32,33].

We now discuss an immediate consequence of our formulation. If we consider a system as depicted in

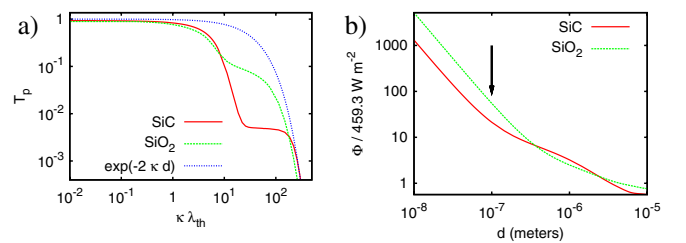


FIG. 4 (color online). Plot of (a) \bar{T}_p^{12} ($d = 100$ nm and $T = 300$ K) and (b) resulting heat flux Φ for SiC and silica [40] normalized to the blackbody value $\Phi_{\text{BB}} = 459.3 \text{ W m}^{-2}$.

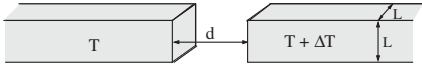


FIG. 5. Sketch of a setup suitable for measuring the quantized radiative conductance between two wires with a cross section $L \times L$.

Fig. 5, we observe that the two wires have a finite transverse cross section $L \times L$. Hence, the electromagnetic modes are quantized for L on the order of λ_{th} as shown for surface plasmon polaritons in Ref. [34], and one expects to observe a radiative conductance of the gap with a discrete NOM similar to the quantized conductance of an aperture [35,36]. An experiment similar to the work reported in Refs. [37,38] should be feasible.

In summary, we have presented a Landauer-like reformulation for the nanoscale RHT putting it on the same footing as the mesoscopic electron transport. In particular, we have introduced a mean transmission coefficient which is shown to fulfill all the properties needed to give a clear understanding of the heat flux on the nanoscale in terms of the DOS or NOM. In addition, we have proposed a near-field heat transfer experiment for measuring the quantized conductance.

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